

Notice of References Cited	Application/Control No. 10/528,529	Applicant(s)/Patent Under Reexamination VANDER VEEN ET AL.	
	Examiner Nam Huynh	Art Unit 2617	Page-1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,813,344	11-2004	Lemke, Steve	379/142.06
*	B	US-5,408,528	04-1995	Carlson et al.	379/211.02
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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